

Notice of References Cited		Application/Control No. 10/755,032	Applicant(s)/Patent Under Reexamination IKENO, HIDEO	
		Examiner ANTHONY MEJIA	Art Unit 2451	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,146,412	12-2006	Turnbull, Paul F.	709/220
*	B	US-2002/0129107	09-2002	Loughran et al.	709/206
*	C	US-2002/0099782	07-2002	Bando et al.	709/206
*	D	US-7,065,560	06-2006	Erickson et al.	709/219
*	E	US-2003/0135613	07-2003	Yoshida et al.	709/224
*	F	US-2003/0086122	05-2003	Parry, Travis J.	358/402
*	G	US-2006/0244986	11-2006	Ferlitsch, Andrew R.	358/001.13
H	US-				
I	US-				
J	US-				
K	US-				
L	US-				
M	US-				

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.